

IGBT3 Chip Medium Power

Features:

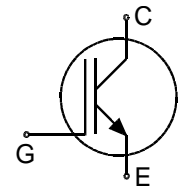
- 650V Trench & Field Stop technology
- high short circuit capability, self limiting short circuit current
- positive temperature coefficient
- easy paralleling
- Qualified according to JEDEC for target applications

Recommended for:

- power modules

Applications:

- drives



Chip Type	V _{CE}	I _{CN}	Die Size	Package
IGC28T65T8M	650V	50A	6.57 x 4.2 mm ²	sawn on foil

Mechanical Parameters

Die size	6.57 x 4.2		mm ²
Emitter pad size (incl. gate pad)	See chip drawing		
Gate pad size	0.817 x 1.52		
Area total	27.6		
Thickness	80		µm
Wafer size	200		mm
Max.possible chips per wafer	974		
Passivation frontside	Photoimide		
Pad metal	3200 nm AlSiCu		
Backside metal	Ni Ag –system		
Die bond	Electrically conductive epoxy glue and soft solder		
Wire bond	Al, <500µm		
Reject ink dot size	Ø 0.65mm ; max 1.2mm		
Storage environment	for original and sealed MBB bags	Ambient atmosphere air, Temperature 17°C – 25°C, < 6 month	
	for open MBB bags	Acc. to IEC62258-3: Atmosphere >99% Nitrogen or inert gas, Humidity <25%RH, Temperature 17°C – 25°C, < 6 month	



IGC28T65T8M

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-Emitter voltage, $T_{vj} = 25\text{ °C}$	V_{CE}	650	V
DC collector current, limited by $T_{vj\text{ max}}$	I_C	¹⁾	A
Pulsed collector current, t_p limited by $T_{vj\text{ max}}$ ²⁾	$I_{C,puls}$	150	A
Gate emitter voltage	V_{GE}	±20	V
Operating junction temperature	T_{vj}	-40 ... +175	°C
Short circuit data ²⁾³⁾ $V_{GE} = 15V$, $V_{CC} = 360V$, $T_{vj} = 150\text{ °C}$	t_{SC}	10	µs

¹⁾ depending on thermal properties of assembly

²⁾ not subject to production test - verified by design/characterization

³⁾ allowed number of short circuits: <1000; time between short circuits: >1s.

Static Characteristics (tested on wafer), $T_{vj} = 25\text{ °C}$

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-Emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}=0V$, $I_C=4\text{ mA}$	650			V
Collector-Emitter saturation voltage	V_{CEsat}	$V_{GE}=15V$, $I_C=50A$	1.08	1.55	1.82	
Gate-Emitter threshold voltage	$V_{GE(th)}$	$I_C=800\mu A$, $V_{GE}=V_{CE}$	5.1	5.8	6.4	
Zero gate voltage collector current	I_{CES}	$V_{CE}=650V$, $V_{GE}=0V$			0.28	µA
Gate-Emitter leakage current	I_{GES}	$V_{CE}=0V$, $V_{GE}=20V$			600	nA
Integrated gate resistor	r_G			none		Ω

Electrical Characteristics (not subject to production test - verified by design / characterization)

Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	
Collector-Emitter saturation voltage	V_{CEsat}	$V_{GE}=15V$, $I_C=50A$, $T_{vj}=150\text{ °C}$		1.75		V
Input capacitance	C_{ies}	$V_{CE}=25V$, $V_{GE}=0V$, $f=1\text{ MHz}$ $T_{vj}=25\text{ °C}$		3140		pF
Reverse transfer capacitance	C_{res}			93		



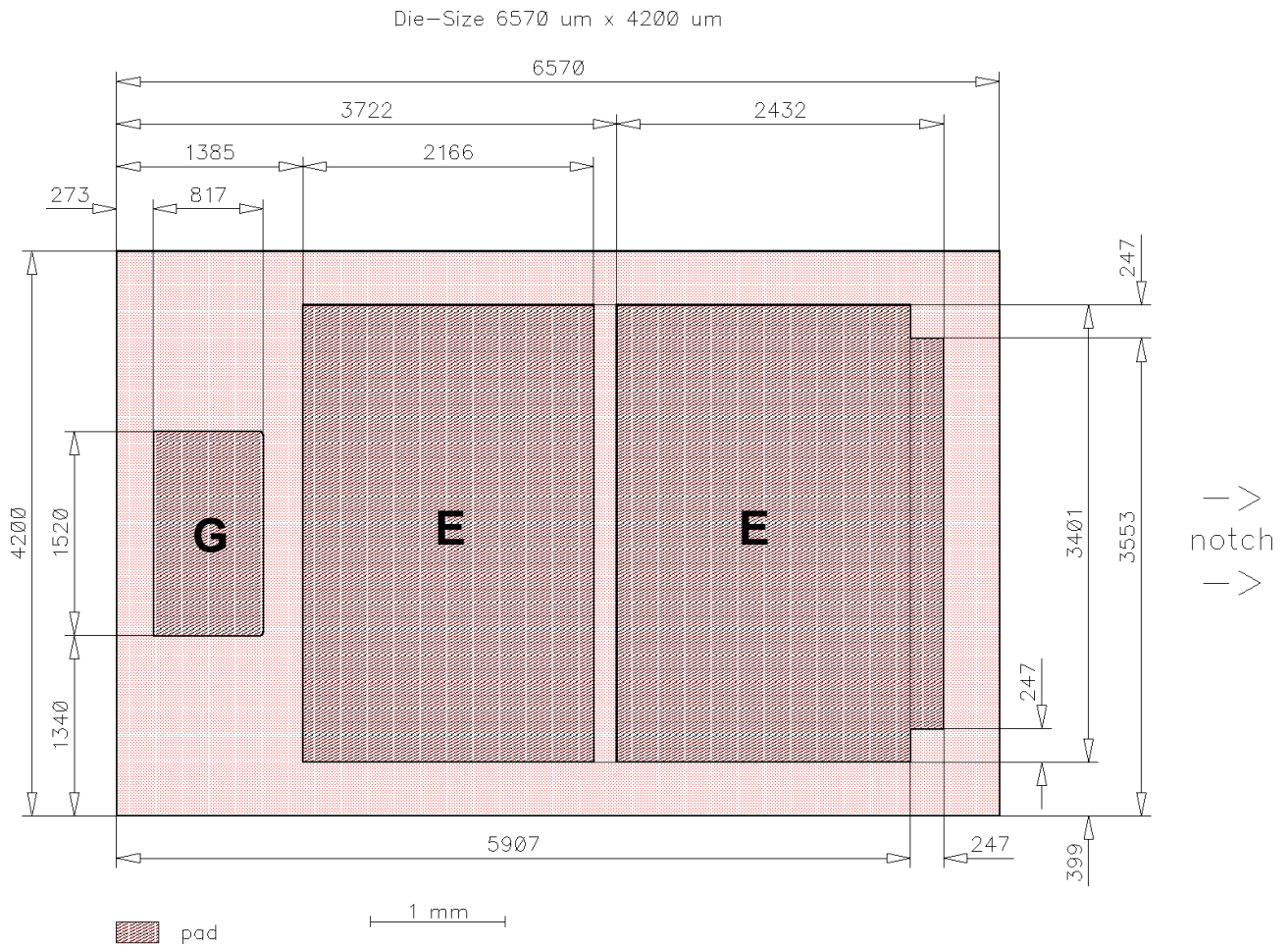
IGC28T65T8M

Further Electrical Characteristic

Switching characteristics and thermal properties are depending strongly on module design and mounting technology and can therefore not be specified for a bare die.

This chip data sheet refers to the device data sheet	FS50R07N2E4	Rev 2.0
--	-------------	---------

Chip Drawing



E = Emitter

G = Gate



IGC28T65T8M

Description

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Revision History

Version	Subjects (major changes since last revision)	Date

Published by
Infineon Technologies AG
81726 Munich, Germany
© 2012 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.
The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

单击下面可查看定价，库存，交付和生命周期等信息

[>>Infineon Technologies\(英飞凌\)](#)